

Notice of References Cited

Application/Control No.

10/581,322

Applicant(s)/Patent Under
Reexamination
FUKUI ET AL.

Examiner

SUN JAE Y. LOEWE

Art Unit

1626

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Filzen et al., caplus an 2003:818386, RN 613239-32-0
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